


Search Notes 	Application/Control No. 10065159	Applicant(s)/Patent Under Reexamination TKACZYK ET AL.
	Examiner Nguyen, Tran N	Art Unit 3626

SEARCHED			
Class	Subclass	Date	Examiner
705	2-3 (cursory with keyword)	05/30/2007	Nguyen, Tran N

SEARCH NOTES		
Search Notes	Date	Examiner
705/7 (consulted B. Van Doren A.U. 3623)	03/07/2007	Nguyen, Tran N
US patent database (EAST)	05/30/2007	Nguyen, Tran N
Reviewed IFW record of 09/655,667	05/30/2007	Nguyen, Tran N
Please see attachment for Examiner's search strategy.		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner